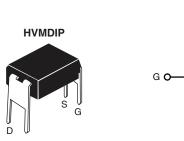
Vishay Siliconix



Power MOSFET



N-Channel MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	10	100				
R _{DS(on)} (Ω)	V _{GS} = 5 V	0.54				
Q _g (Max.) (nC)	6.	6.1				
Q _{gs} (nC)	2.6	2.6				
Q _{gd} (nC)	3.0	3.3				
Configuration	Sing	Single				

FEATURES

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · For automatic insertion
- End stackable
- · Logic-level gate drive
- R_{DS(on)} specified at V_{GS} = 4 V and 5 V
- 175 °C operating temperature
- · Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION				
Package	HVMDIP			
Lead (Pb)-free	IRLD110PbF			

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-source voltage			V_{DS}	100			
Gate-source voltage			V_{GS}	± 10	- V		
Continuous drain current	Vocath V	T _A = 25 °C		1	A		
Continuous drain current		T _A = 100 °C	I _D	0.70			
Pulsed drain current ^a			I _{DM}	8	1		
Linear derating factor				0.0083	W/°C		
Single pulse avalanche energy ^b			E _{AS}	100	mJ		
Repetitive avalanche current a			I _{AR}	1	Α		
Repetitive avalanche energy ^a			E _{AR}	0.13	mJ		
Maximum power dissipation T _A = 25 °C		P_{D}	1.3	W			
Peak diode recovery dv/dt ^c			dV/dt	5.5	V/ns		
Operating junction and storage temperature range			T _J , T _{stg}	- 55 to + 175	- °C		
Soldering rRecommendations (peak temperature) d	For	10 s		300 ^d	7 -0		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 6.4 mH, R_g = 25 Ω , I_{AS} = 5.6 A (see fig. 12)
- c. $I_{SD} \le 5.6$ A, $dI/dt \le 75$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C
- d. 1.6 mm from case



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THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYP.	MAX.	UNIT			
Maximum Junction-to-Ambient	R _{thJA}	-	120	°C/W			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static				L	L	L	1	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I _D = 1 mA	-	0.12	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	1	-	2	V	
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 10 V	-	-	± 100	nA	
7 0 1 1/1 1 5 1 0 1		V _{DS} =	V _{DS} = 100 V, V _{GS} = 0 V		-	25		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V	, V _{GS} = 0 V, T _J = 150 °C	-	-	250	μA	
	_	$V_{GS} = 5 V$	I _D = 0.60 A ^b	-	-	0.54		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4 V	I _D = 0.50 A ^b	-	-	0.76	Ω	
Forward Transconductance	9 _{fs}	V _{DS} =	50 V, I _D = 0.60 A ^b	1.3	-	-	S	
Dynamic								
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1 \text{ MHz}, \text{ see fig. 5}$		-	250	-	pF	
Output Capacitance	C _{oss}			-	80	-		
Reverse Transfer Capacitance	C _{rss}			-	15	-		
Total Gate Charge	Qg		I _D = 5.6 A, V _{DS} = 80 V, see fig. 6 and 13 ^b	-	-	6.1	nC	
Gate-Source Charge	Q_gs	$V_{GS} = 5 V$		-	-	2.6		
Gate-Drain Charge	Q _{gd}	1	See lig. 0 and 15	-	-	3.3		
Turn-On Delay Time	t _{d(on)}				9.3	-	ns	
Rise Time	t _r	$V_{DD} = 50 \text{ V}, \text{ I}_D = 5.6 \text{ A},$ $R_g = 12 \ \Omega, \text{ R}_D = 8.4 \ \Omega, \text{ see fig. } 10^b$		-	4.7	-		
Turn-Off Delay Time	t _{d(off)}			-	16	-		
Fall Time	t _f			-	17	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4	-	-11	
Internal Source Inductance	L _S			-	6	-	- nH	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1	^	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	8	A	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 1 A, V _{GS} = 0 V ^b		-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	T 05 00 1	E C A -11/-11 - 100 A / h	-	110	130	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 5.6 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^b$		-	0.50	0.65	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	on is dor	ninated b	v L _s and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

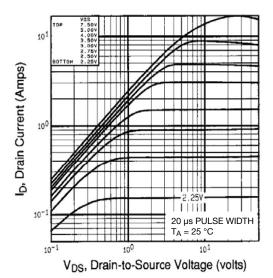


Fig. 1 - Typical Output Characteristics, T_A = 25 °C

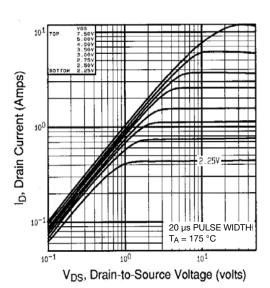


Fig. 1 - Typical Output Characteristics, T_A = 175 °C

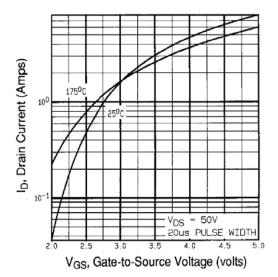


Fig. 2 - Typical Transfer Characteristics

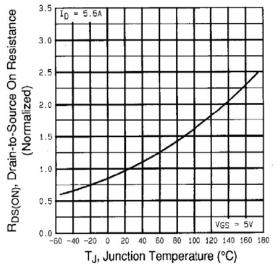


Fig. 3 - Normalized On-Resistance vs. Temperature



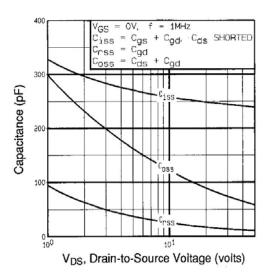


Fig. 4 - Typical Capacitance vs. Drain-to-Source Voltage

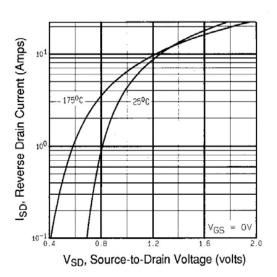


Fig. 6 - Typical Source-Drain Diode Forward Voltage

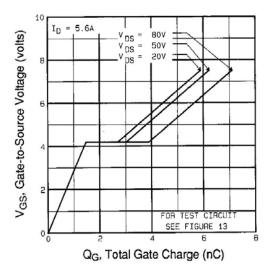


Fig. 5 - Typical Gate Charge vs. Gate-to-Source Voltage

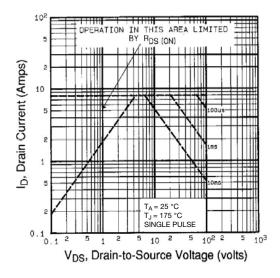


Fig. 7 - Maximum Safe Operating Area



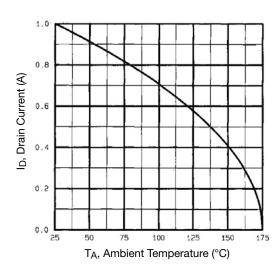


Fig. 8 - Maximum Drain Current vs. Ambient Temperature

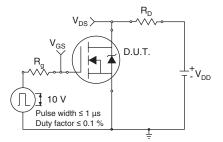


Fig. 9 - Switching Time Test Circuit

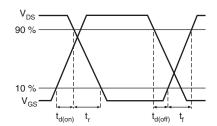


Fig. 10 - Switching Time Waveforms

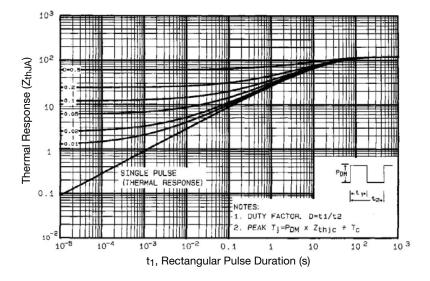


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



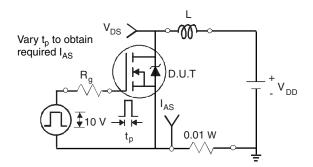


Fig. 12 - Unclamped Inductive Test Circuit

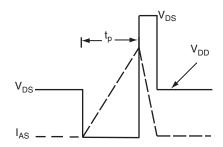


Fig. 13 - Unclamped Inductive Waveforms

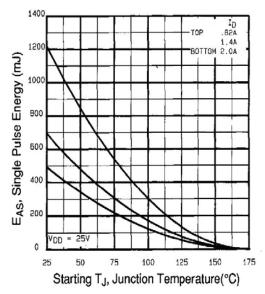


Fig. 14 - Maximum Avalanche Energy vs. Drain Current

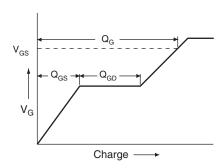


Fig. 15 - Basic Gate Charge Waveform

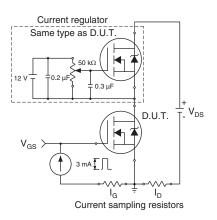
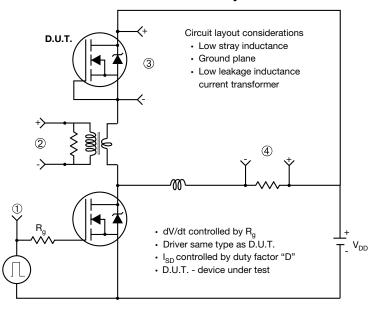


Fig. 16 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



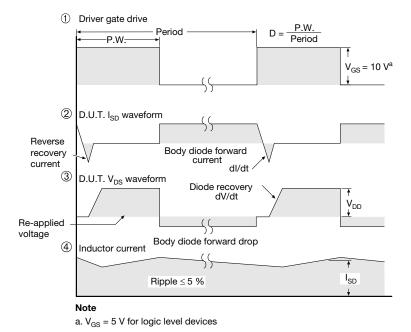


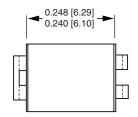
Fig. 17 - For N-Channel

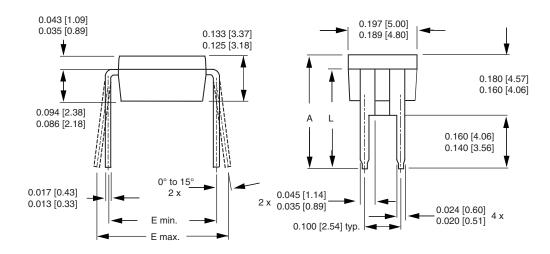
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Vishay Siliconix

HVM DIP (High voltage)





	INCHES		MILLIMETERS	
DIM.	MIN.	MAX.	MIN.	MAX.
A	0.310	0.330	7.87	8.38
E	0.300	0.425	7.62	10.79
L	0.270	0.290	6.86	7.36

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.

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Revision: 06-Sep-10 1



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